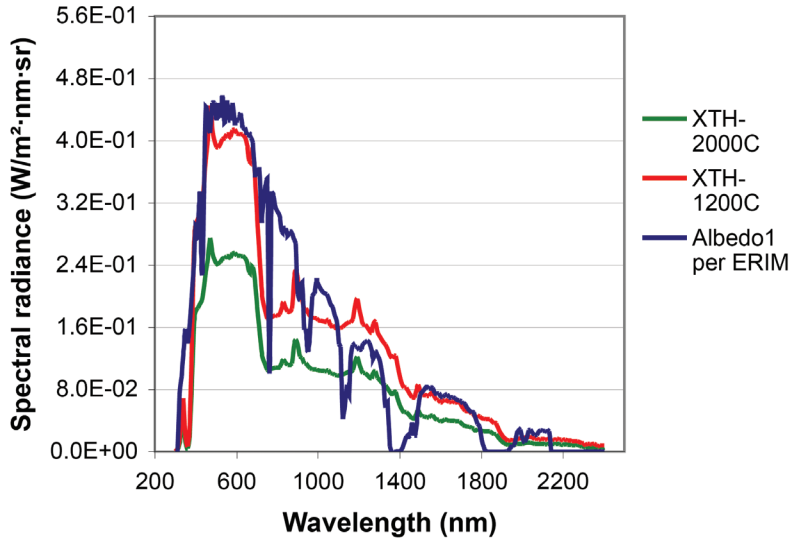


# SOLAR SPECTRUM UNIFORM SOURCE SYSTEM

## Ideal Lambertian Radiance Calibration Sources

### SPECTRAL RADIANCE PLOT



### SPECTRAL SHAPE SIMULATION

Labsphere's Solar Spectrum Uniform Source System approximates the spectral radiance albedo1 (defined by ERIM) by combining xenon and tungsten halogen sources within an integrating sphere. The system is designed to duplicate the spectral shape of solar radiation while also approximating any spectrum with color temperature ranges from 3000 K to 6000 K. The complete system is available in two models depending upon the customer's output radiance and illumination area requirements.

Labsphere's XTH-1200C and XTH-2000C systems feature a 12-inch (30 cm) diameter uniform source integrating sphere with 4-inch (10 cm) diameter port, and a 20-inch (51 cm) diameter uniform source integrating sphere with an 8-inch (20 cm) diameter port, respectively. The spheres are coated with Spectrafect® white reflectance coating which offers near-Lambertian characteristics and provides exceptional uniform radiance. A spectrometer-based spectral irradiance monitor enables users to accurately monitor the spectral distribution of the sphere for any lamp configuration or variable attenuator position. A photopic detector is also included for luminance monitoring. The system includes spectrometer software and uniform source control system software.

### AUTOMATED CONTROL

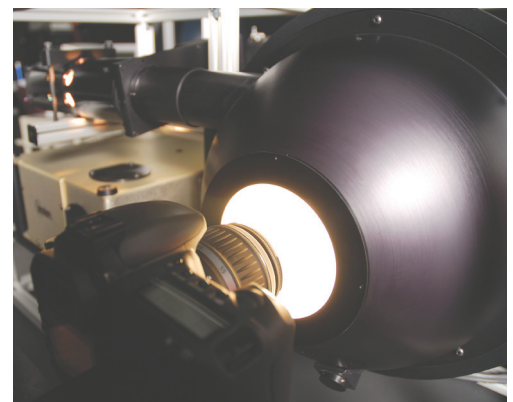
Users can automatically control and monitor the spectral radiance through the exit port from zero to maximum output levels with Labsphere's motorized variable attenuators (VA-200-SC) and motor controllers (MC-1000). A high-dynamic range, low-noise CCD-based spectrometer monitors the spectral irradiance from 350 to 1050 nm. Labsphere's highly sensitive SDA-050-P-RTA detector and SC 6000 radiometer are calibrated for luminance responsivity and enable users to independently monitor luminance through the exit port in units of cd/m<sup>2</sup> or fL. The combination of xenon and tungsten halogen sources allow users to obtain correlated color temperature spectrums from 3000 K to 6000 K.

### FEATURES:

- Radiance Uniformity >98%
- Approximates 100% Albedo Shape
- Approximates ASTM Standard D65
- Variable Correlated Color Temperatures between 3000 K and 6000 K
- Two High-Performance Systems Available
- Multiple Detector Options
- System Calibration Traceable to NIST
- CCD-based Spectrometer Monitoring from 350 - 1050 nm
- Photopic Detector for Luminance Monitoring

### APPLICATIONS:

- Lambertian Solar Simulator
- Dynamic Range, Linearity and Uniformity Testing of Focal Plane Arrays
- Characterization of Space-based Imager Systems
- Testing of Speed Video/Film Systems
- Single Element Broadband Sensor Testing
- Photovoltaic and Quantum Efficiency Testing



XTH-1200C SYSTEM

# Specifications

## Model and Description

Continuous Xenon Tungsten Halogen  
Uniform Source System

## XTH-1200C

AA-00900-000

## XTH-2000C

AA-00566-000

## System Includes

12- or 20-inch Spectrafect Integrating Sphere  
Light Source, EHLS-200-150  
Halogen Lamp Power Supply, LPS-150-0625  
Radiometer/Photometer, SC 6000  
Detectors, SDA-050-P-RTA-CX  
Variable Attenuators, (2) VA-200-SC  
Motor Controller, (2) MC-1000  
CCD-Based Spectrometer  
Spectrometer Software  
Labsphere USS Control Software  
Calibration, Spectral Irradiance (350 - 1050 nm)  
SCC-LU, Luminance

N/A  
N/A  
AS-02656-625  
AS-02702-000  
AS-02522-301  
AS-02450-200  
AS-02609-000  
OOI USB 2000+  
OOI SpectraSuite  
AS-02743-001  
N/A  
SCC-LU

N/A  
N/A  
AS-02656-625  
AS-02702-000  
AS-02522-301  
AS-02450-200  
AS-02609-000  
OOI USB 2000+  
OOI SpectraSuite  
AS-02743-001  
N/A  
SCC-LU

## Typical System Properties and Performance

Luminance Range:	0 - 20,500 cd/m <sup>2</sup> @ 6000 K	0 - 7000 cd/m <sup>2</sup> @ 6000 K
Luminance Uniformity*:	>98%	>98%
Correlated Color Temperature:	3000 K - 6000 K (variable)	3200 K - 6000 K (variable)
Sphere Coating:	Spectrafect	Spectrafect
Sphere Coating Reflectance: (nominal)	98%	98%

\* Applies at maximum radiance, uniformity may vary at lower radiance levels.

## Photopic Detector Assembly

Active Area:  
Range:  
Connector:

SDA-050-P-RTA-CX  
4.5 mm<sup>2</sup>  
Visible  
BNC

SDA-050-P-RTA-CX  
4.5 mm<sup>2</sup>  
Visible  
BNC

## Radiometer/Photometer

Power Requirements:  
Current Dynamic Range:  
Weight:  
Dimension: (W x D x H)

SC 6000  
110./220 VAC, 50/60 Hz  
1pA - 1 mA  
4.1 lbs. (1.86 kg.)  
1.75 x 8.25 x 10.5 in  
(4.4 x 20.9 x 26.4 cm)  
Ethernet

SC 6000  
110./220 VAC, 50/60 Hz  
1pA - 1 mA  
4.1 lbs. (1.86 kg.)  
1.75 x 8.25 x 10.5 in  
(4.4 x 20.9 x 26.4 cm)  
Ethernet

Computer Interface:

## Spectrometer

Integration Time:  
Dynamic Range:  
Signal-to-Noise:  
Readout Noise: (Single Dark Spectrum)  
Stray Light:  
Spectrometer Channels:  
Interface:

OOI USB 2000+  
10ms - >60sec  
2 x 108  
250:1 single acquisition  
3.5 counts RMS, 20 counts peak-to-peak  
<0.05% at 600 nm; <0.10% at 435 nm  
One  
USB USB 2.0, 480 Mbps  
RS-232 2-wire RS-232

OOI USB 2000+  
10ms - >60sec  
2 x 108  
250:1 single acquisition  
3.5 counts RMS, 20 counts peak-to-peak  
<0.05% at 600 nm; <0.10% at 435 nm  
One  
USB USB 2.0, 480 Mbps  
RS-232 2-wire RS-232

## Optional Accessories/Calibrations

Uniformity Mapping:  
Radiance Calibration:

USC-PM  
SCC-RA

## Recommended Computer Requirements

Operating System:  
Drives:

Windows 98® 2<sup>nd</sup> Edition, Windows 2000® PE or later  
3 1/2" Disk Drive or 1 CD-ROM Drive